Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/603,790	KANG, WON-SEOK	
Examiner	Art Unit	
Toan Ton	2871	

SEARCHED				
Class	Subclass	Date	Examiner	
349	113,38	5/25/2005	TTON	
	139,155			
	156			
			:	

INTERFERENCE SEARCHED				
Class	Subclass	Date .	Examiner	
			_	

	SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR		
EAST liquid crystal reflect\$ pixel electrode tft data line/bus overlap\$,cover\$ complet\$,full\$4 spacer, spacing redundan\$	5/25/2005	TTON		